

FEATURES

33 V supply range
Fully specified at +12 V, ±15 V
130 Ω on resistance
No V_L supply required
3 V logic-compatible inputs
Rail-to-rail operation
16-lead TSSOP and 16-lead SOIC
Typical power consumption: <0.03 μW

APPLICATIONS

Signal switching
Battery-powered systems
Communication systems
Audio/video signal routing

GENERAL DESCRIPTION

The ADG1311/ADG1312/ADG1313 are monolithic CMOS devices containing four independently selectable switches designed on a CMOS process.

The ADG1311/ADG1312/ADG1313 contain four independent single-pole/single-throw (SPST) switches. The ADG1311 and ADG1312 differ only in that the digital control logic is inverted. The ADG1311 switches are turned on with Logic 0 on the appropriate control input, while Logic 1 is required for the ADG1312. The ADG1313 has two switches with digital control logic similar to the ADG1311; the logic is inverted on the other two switches. The ADG1313 exhibits break-before-make switching action for use in multiplexer applications.

Each switch conducts equally well in both directions when on and has an input signal range that extends to the supplies. In the off condition, signal levels up to the supplies are blocked.

FUNCTIONAL BLOCK DIAGRAM

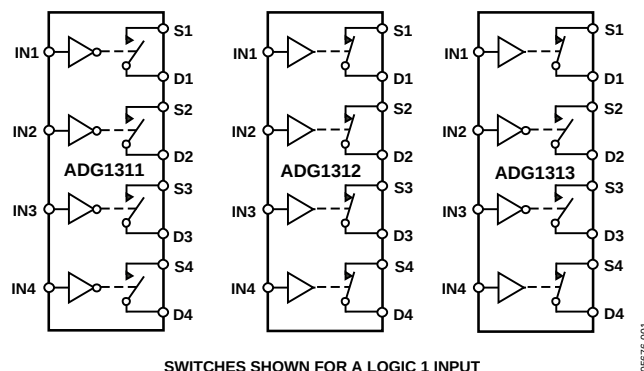


Figure 1.

PRODUCT HIGHLIGHTS

- 3 V logic-compatible digital inputs: $V_{IH} = 2.0$ V, $V_{IL} = 0.8$ V.
- No V_L logic power supply required.
- 16-lead TSSOP and SOIC packages.

Rev. A

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REVISION HISTORY

2/09—Rev. 0 to Rev. A	
Changes to Power Requirements, I_{DD} , Digital Inputs = 5 V	
Parameter, Table 1.....	3
Changes to Power Requirements, I_{DD} , Digital Inputs = 5 V	
Parameter, Table 2.....	4
10/05—Revision 0: Initial Version	

SPECIFICATIONS

DUAL SUPPLY

$V_{DD} = 15\text{ V} \pm 10\%$, $V_{SS} = -15\text{ V} \pm 10\%$, $GND = 0\text{ V}$, unless otherwise noted.

Table 1.

Parameter	Y Version ¹		Unit	Test Conditions/Comments
	25°C	–40°C to +105°C		
ANALOG SWITCH				
Analog Signal Range		V_{DD} to V_{SS}	V	$V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$; see Figure 10 $V_{DD} = +13.5\text{ V}$, $V_{SS} = -13.5\text{ V}$ $V_S = \pm 10\text{ V}$, $I_S = -1\text{ mA}$
On Resistance (R_{ON})	130	230	Ω typ	
	200		Ω max	
On Resistance Match Between Channels (ΔR_{ON})	5		Ω typ	
	10		Ω max	$V_S = -5\text{ V}/0\text{ V}/+5\text{ V}$; $I_S = -1\text{ mA}$
On Resistance Flatness ($R_{FLAT(ON)}$)	25		Ω typ	
	65		Ω max	
LEAKAGE CURRENTS				
Source Off Leakage, I_S (Off)	± 10		nA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$ $V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$; see Figure 11
Drain Off Leakage, I_D (Off)	± 10		nA typ	$V_S = \pm 10\text{ V}$, $V_D = \mp 10\text{ V}$; see Figure 11
Channel On Leakage, I_D , I_S (On)	± 10		nA typ	$V_S = V_D = \pm 10\text{ V}$; see Figure 12
DIGITAL INPUTS				
Input High Voltage, V_{INH}		2.0	V min	$V_{IN} = V_{INL}$ or V_{INH}
Input Low Voltage, V_{INL}		0.8	V max	
Input Current, I_{INL} or I_{INH}	0.005		μA typ	
		± 0.1	μA max	
Digital Input Capacitance, C_{IN}	2.5		pF typ	
DYNAMIC CHARACTERISTICS ²				
t_{ON}	105		ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	125	180	ns max	$V_S = 10\text{ V}$; see Figure 13
t_{OFF}	40		ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
	50	60	ns max	$V_S = 10\text{ V}$; see Figure 13
Break-Before-Make Time Delay, t_D (ADG1313 Only)	25	10	ns typ	$R_L = 300\ \Omega$, $C_L = 35\text{ pF}$
			ns min	$V_{S1} = V_{S2} = 10\text{ V}$; see Figure 14
Charge Injection	2		pC typ	$V_S = 0\text{ V}$, $R_S = 0\ \Omega$, $C_L = 1\text{ nF}$; see Figure 15
Off Isolation	80		dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 16
Channel-to-Channel Crosstalk	90		dB typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$, $f = 1\text{ MHz}$; see Figure 17
–3 dB Bandwidth	600		MHz typ	$R_L = 50\ \Omega$, $C_L = 5\text{ pF}$; see Figure 18
C_S (Off)	5		pF typ	
C_D (Off)	5		pF typ	
C_D , C_S (On)	10		pF typ	
POWER REQUIREMENTS				
I_{DD}	0.001		μA typ	$V_{DD} = +16.5\text{ V}$, $V_{SS} = -16.5\text{ V}$
		1.0	μA max	Digital inputs = 0 V or V_{DD}
I_{DD}	220		μA typ	Digital inputs = 5 V
		380	μA max	
I_{SS}	0.001		μA typ	Digital inputs = 0 V or V_{DD}
		1.0	μA max	
I_{SS}	0.001		μA typ	Digital inputs = 5 V
		1.0	μA max	

¹ Temperature range for Y Version is –40°C to +105°C.

² Guaranteed by design, not subject to production test.

ADG1311/ADG1312/ADG1313

SINGLE SUPPLY

$V_{DD} = 12\text{ V} \pm 10\%$, $V_{SS} = 0\text{ V}$, $GND = 0\text{ V}$, unless otherwise noted.

Table 2.

Parameter	Y Version ¹		Unit	Test Conditions/Comments
	25°C	–40°C to +105°C		
ANALOG SWITCH				
Analog Signal Range		0 V to V _{DD}	V	
On Resistance (R _{ON})	325	520	Ω typ	V _S = 0 V – 10 V, I _S = –1 mA; see Figure 10
	500		Ω max	V _{DD} = 10.8 V, V _{SS} = 0 V
On Resistance Match Between Channels (ΔR _{ON})	10		Ω typ	V _S = 0 V – 10 V, I _S = –1 mA
	15		Ω max	
On Resistance Flatness (R _{FLAT(ON)})	65		Ω typ	V _S = 3 V/6 V/9 V, I _S = –1 mA
LEAKAGE CURRENTS				
Source Off Leakage, I _S (Off)	±10		nA typ	V _{DD} = 13.2 V, V _{SS} = 0 V
Drain Off Leakage, I _D (Off)	±10		nA typ	V _S = 1 V/10 V, V _D = 10 V/1 V; see Figure 11
Channel On Leakage, I _D , I _S (On)	±10		nA typ	V _S = 1 V/10 V, V _D = 10 V/1 V see Figure 11
				V _S = V _D = 1 V or 10 V; see Figure 12
DIGITAL INPUTS				
Input High Voltage, V _{INH}		2.0	V min	
Input Low Voltage, V _{INL}		0.8	V max	
Input Current, I _{INL} or I _{INH}	0.001		μA typ	V _{IN} = V _{INL} or V _{INH}
		±0.1	μA max	
Digital Input Capacitance, C _{IN}	3		pF typ	
DYNAMIC CHARACTERISTICS ²				
t _{ON}	120		ns typ	R _L = 300 Ω, C _L = 35 pF
	155	210	ns max	V _S = 8 V; see Figure 13
t _{OFF}	45		ns typ	R _L = 300 Ω, C _L = 35 pF
	65	80	ns max	V _S = 8 V; see Figure 13
Break-Before-Make Time Delay, t _D (ADG1313 Only)	50		ns typ	R _L = 300 Ω, C _L = 35 pF
		10	ns min	V _{S1} = V _{S2} = 8 V; see Figure 14
Charge Injection	2		pC typ	V _S = 6 V, R _S = 0 Ω, C _L = 1 nF; see Figure 15
Off Isolation	80		dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 16
Channel-to-Channel Crosstalk	90		dB typ	R _L = 50 Ω, C _L = 5 pF, f = 1 MHz; see Figure 17
–3 dB Bandwidth	500		MHz typ	R _L = 50 Ω, C _L = 5 pF; see Figure 18
C _S (Off)	5		pF typ	
C _D (Off)	5		pF typ	
C _D , C _S (On)	10		pF typ	
POWER REQUIREMENTS				
I _{DD}	0.001		μA typ	V _{DD} = 13.2 V
		1.0	μA max	Digital inputs = 0 V or V _{DD}
I _{DD}	220		μA typ	Digital inputs = 5 V
		380	μA max	

¹ Temperature range for Y Version is –40°C to +105°C.

² Guaranteed by design, not subject to production test.

ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$, unless otherwise noted.

Table 3.

Parameter	Rating
V_{DD} to V_{SS}	35 V
V_{DD} to GND	–0.3 V to +25 V
V_{SS} to GND	+0.3 V to –25 V
Analog Inputs ¹	$V_{SS} - 0.3\text{ V}$ to $V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Digital Inputs ¹	GND – 0.3 V to $V_{DD} + 0.3\text{ V}$ or 30 mA, whichever occurs first
Peak Current, S or D	100 mA (pulsed at 1 ms, 10% duty cycle max)
Continuous Current per Channel, S or D	25 mA
Operating Temperature Range Automotive	–40°C to +105°C
Storage Temperature Range	–65°C to +150°C
Junction Temperature	150°C
16-Lead TSSOP, θ_{JA} Thermal Impedance (4-layer board)	112°C/W
16-Lead SOIC, θ_{JA} Thermal Impedance	77°C/W
Reflow Soldering Peak Temperature, Pb free	260°C

¹ Overvoltages at IN, S, or D are clamped by internal diodes. Current should be limited to the maximum ratings given.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Table 4. ADG1311/ADG1312 Truth Table

ADG1311 INx	ADG1312 INx	Switch Condition
0	1	On
1	0	Off

Table 5. ADG1313 Truth Table

ADG1313 INx	Switch 1, 4	Switch 2, 3
0	Off	On
1	On	Off

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



ADG1311/ADG1312/ADG1313

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

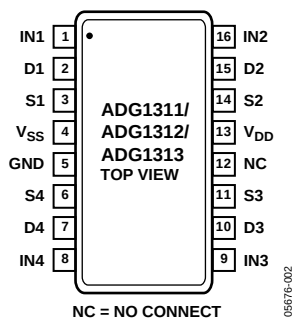


Figure 2. SOIC/TSSOP Pin Configuration

Table 6. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	IN1	Logic Control Input.
2	D1	Drain Terminal. Can be an input or output.
3	S1	Source Terminal. Can be an input or output.
4	V _{SS}	Most Negative Power Supply Potential.
5	GND	Ground (0 V) Reference.
6	S4	Source Terminal. Can be an input or output.
7	D4	Drain Terminal. Can be an input or output.
8	IN4	Logic Control Input.
9	IN3	Logic Control Input.
10	D3	Drain Terminal. Can be an input or output.
11	S3	Source Terminal. Can be an input or output.
12	NC	No Connection.
13	V _{DD}	Most Positive Power Supply Potential.
14	S2	Source Terminal. Can be an input or output.
15	D2	Drain Terminal. Can be an input or output.
16	IN2	Logic Control Input.

TERMINOLOGY

I_{DD}

The positive supply current.

I_{SS}

The negative supply current.

V_D (V_S)

The analog voltage on Terminal D and Terminal S.

R_{ON}

The ohmic resistance between D and S.

R_{FLAT(ON)}

Flatness is defined as the difference between the maximum and minimum value of on resistance, as measured over the specified analog signal range.

I_S (Off)

The source leakage current with the switch off.

I_D (Off)

The drain leakage current with the switch off.

I_D, I_S (On)

The channel leakage current with the switch on.

V_{INL}

The maximum input voltage for Logic 0.

V_{INH}

The minimum input voltage for Logic 1.

I_{INL} (I_{INH})

The input current of the digital input.

C_S (Off)

The off switch source capacitance, measured with reference to ground.

C_D (Off)

The off switch drain capacitance, measured with reference to ground.

C_D, C_S (On)

The on switch capacitance, measured with reference to ground.

C_{IN}

The digital input capacitance.

t_{ON}

The delay between applying the digital control input and the output switching on. See Figure 13.

t_{OFF}

The delay between applying the digital control input and the output switching off. See Figure 13.

Charge Injection

A measure of the glitch impulse transferred from the digital input to the analog output during switching.

Off Isolation

A measure of unwanted signal coupling through an off switch.

Crosstalk

A measure of unwanted signal that is coupled through from one channel to another as a result of parasitic capacitance.

Bandwidth

The frequency at which the output is attenuated by 3 dB.

On Response

The frequency response of the on switch.

Insertion Loss

The loss due to the on resistance of the switch.

TYPICAL PERFORMANCE CHARACTERISTICS

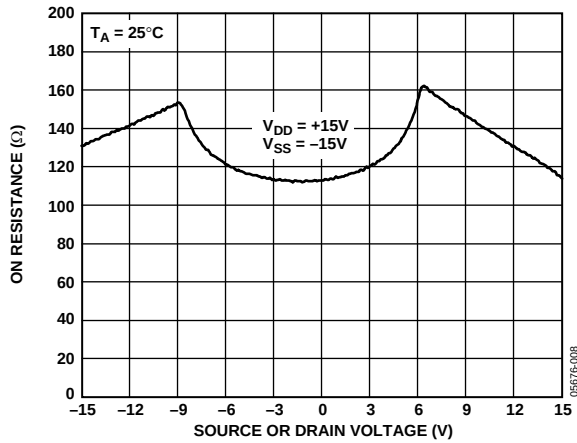


Figure 3. On Resistance as a Function of V_D (V_S) for Dual Supply

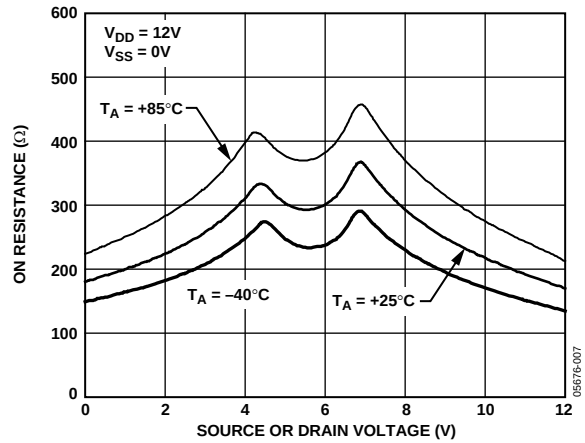


Figure 6. On Resistance as a Function of V_D (V_S) for Different Temperatures, Single Supply

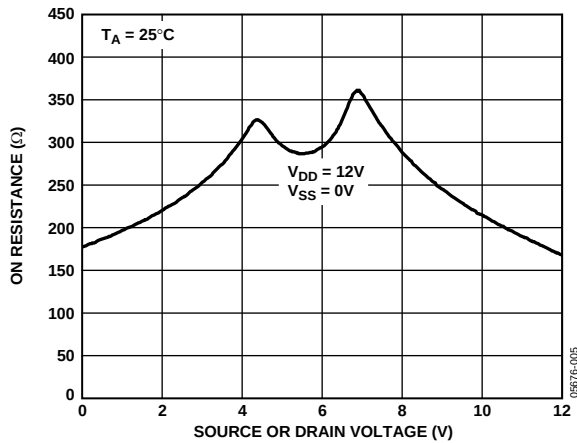


Figure 4. On Resistance as a Function of V_D (V_S) for Single Supply

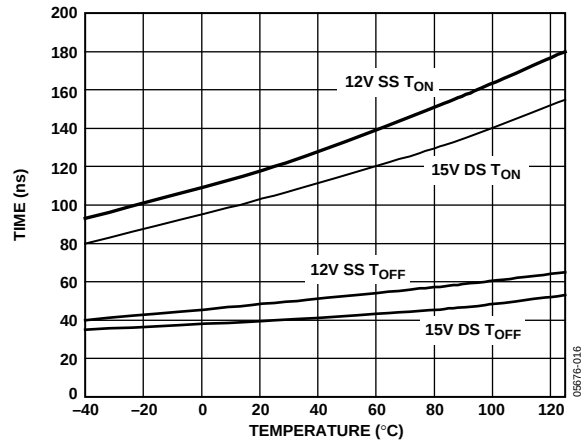


Figure 7. T_{ON}/T_{OFF} Times vs. Temperature

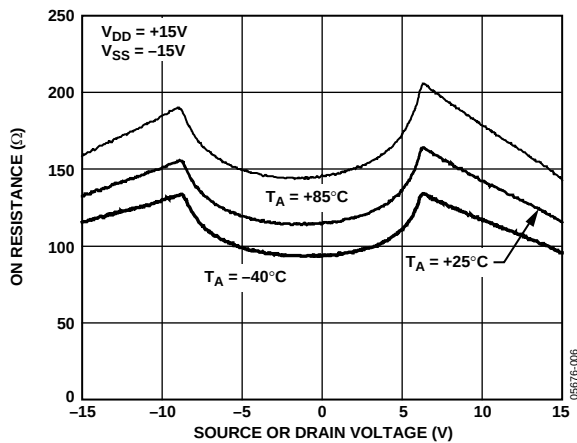


Figure 5. On Resistance as a Function of V_D (V_S) for Different Temperatures, Dual Supply

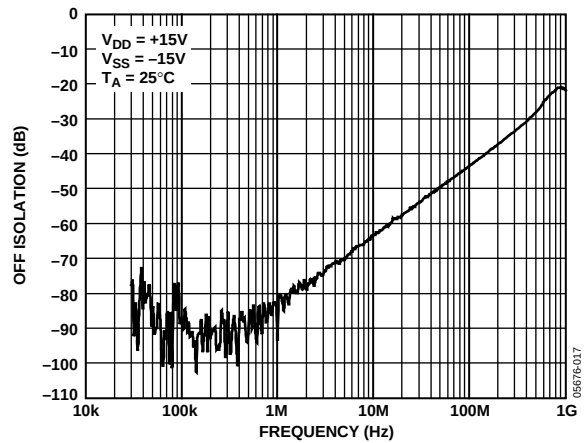


Figure 8. Off Isolation vs. Frequency

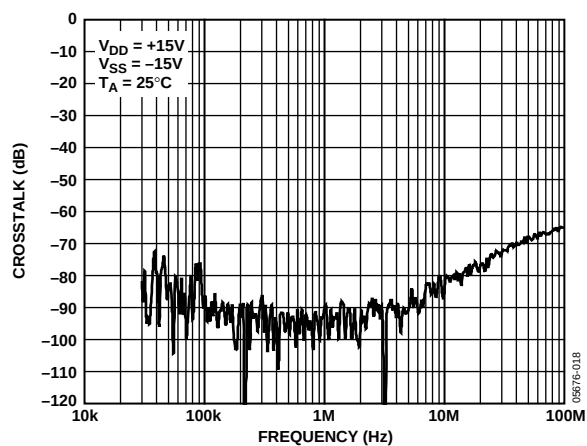


Figure 9. Crosstalk vs. Frequency

TEST CIRCUITS

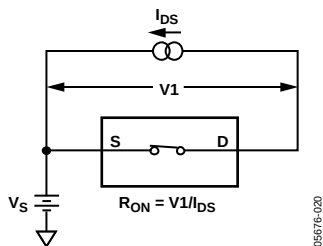


Figure 10. On Resistance

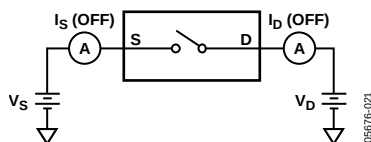


Figure 11. Off Leakage

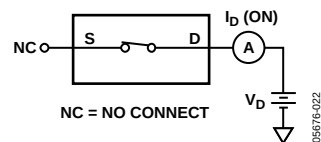


Figure 12. On Leakage

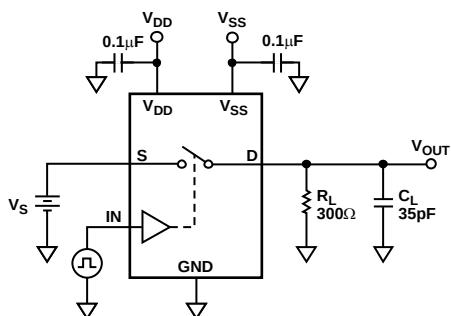


Figure 13. Switching Times

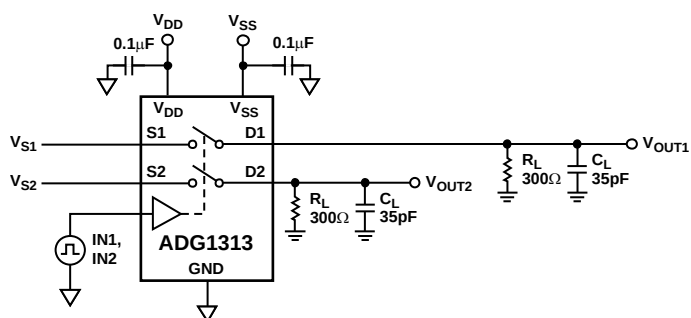


Figure 14. Break-Before-Make Time Delay

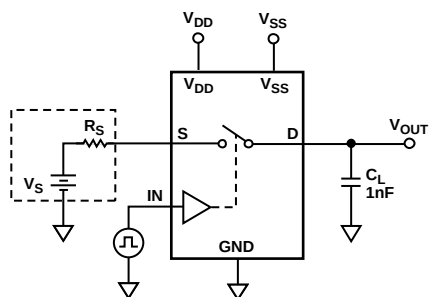


Figure 15. Charge Injection

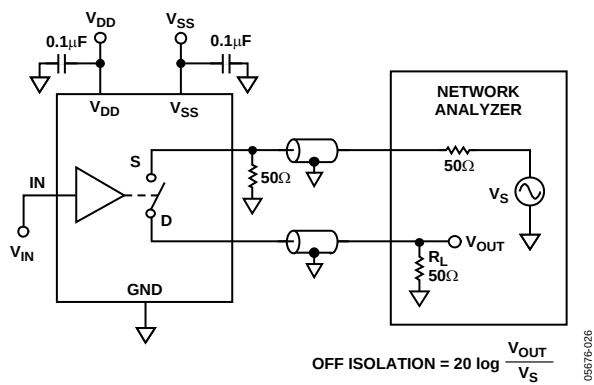


Figure 16. Off Isolation

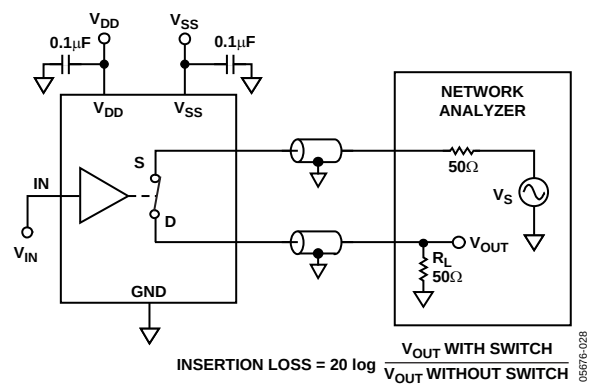


Figure 18. Bandwidth

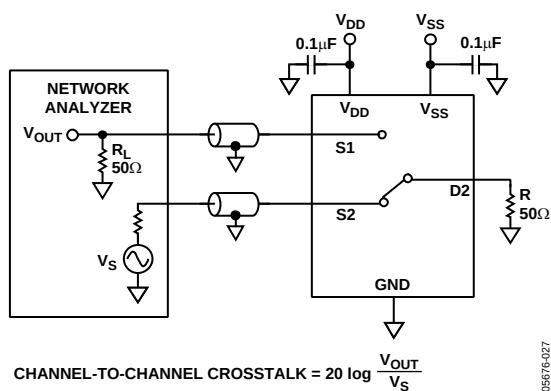
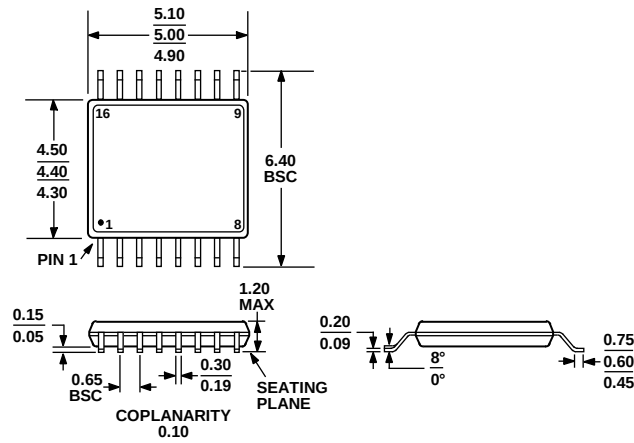


Figure 17. Channel-to-Channel Crosstalk

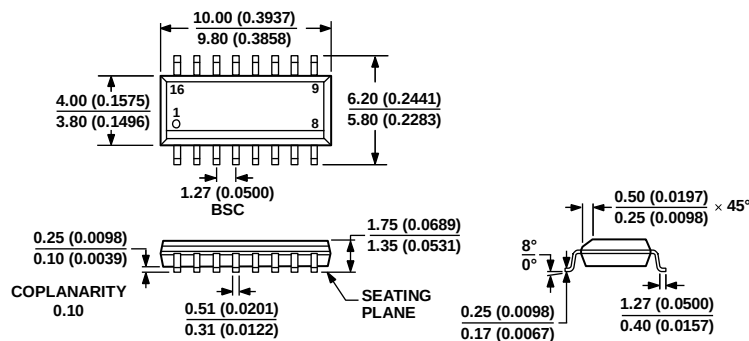
OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 19. 16-Lead Thin Shrink Small Outline Package [TSSOP]
(RU-16)

Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MS-012-AC

CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN.

Figure 20. 16-Lead Standard Small Outline Package [SOIC_N]
Narrow Body (R-16)

Dimensions shown in millimeters and (inches)

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
ADG1311YRUZ ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1311YRUZ-REEL7 ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1311YRZ ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16
ADG1311YRZ-REEL7 ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16
ADG1312YRUZ ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1312YRUZ-REEL7 ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1312YRZ ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16
ADG1312YRZ-REEL7 ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16
ADG1313YRUZ ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1313YRUZ-REEL7 ¹	−40°C to +105°C	16-Lead Thin Shrink Small Outline Package [TSSOP]	RU-16
ADG1313YRZ ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16
ADG1313YRZ-REEL7 ¹	−40°C to +105°C	16-Lead Narrow Body Small Outline Package [SOIC_N]	R-16

¹ Z = RoHS Compliant Part.

Данный компонент на территории Российской Федерации

Вы можете приобрести в компании MosChip.

Для оперативного оформления запроса Вам необходимо перейти по данной ссылке:

<http://moschip.ru/get-element>

Вы можете разместить у нас заказ для любого Вашего проекта, будь то серийное производство или разработка единичного прибора.

В нашем ассортименте представлены ведущие мировые производители активных и пассивных электронных компонентов.

Нашей специализацией является поставка электронной компонентной базы двойного назначения, продукции таких производителей как XILINX, Intel (ex.ALTERA), Vicor, Microchip, Texas Instruments, Analog Devices, Mini-Circuits, Amphenol, Glenair.

Сотрудничество с глобальными дистрибьюторами электронных компонентов, предоставляет возможность заказывать и получать с международных складов практически любой перечень компонентов в оптимальные для Вас сроки.

На всех этапах разработки и производства наши партнеры могут получить квалифицированную поддержку опытных инженеров.

Система менеджмента качества компании отвечает требованиям в соответствии с ГОСТ Р ИСО 9001, ГОСТ РВ 0015-002 и ЭС РД 009

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